

March 2012

FDPC8011S

PowerTrench® Power Clip 25V Asymmetric Dual N-Channel MOSFET

Features

Q1: N-Channel

■ Max $r_{DS(on)} = 7.3 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 12 \text{ A}$

Q2: N-Channel

- Max $r_{DS(on)}$ = 2.1 m Ω at V_{GS} = 4.5 V, I_D = 24 A
- Low inductance packaging shortens rise/fall times, resulting in lower switching losses
- MOSFET integration enables optimum layout for lower circuit inductance and reduced switch node ringing
- RoHS Compliant

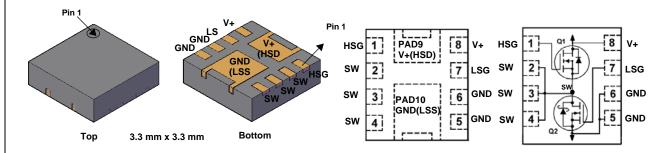


General Description

This device includes two specialized N-Channel MOSFETs in a dual package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous SyncFETTM (Q2) have been designed to provide optimal power efficiency.

Applications

- Computing
- Communications
- General Purpose Point of Load



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

| Symbol | Parameter | | Q1 | Q2 | Units |
|-----------------------------------|---|------------------------|-------------------|-------------------|-------|
| V_{DS} | Drain to Source Voltage | | 25 | 25 | V |
| V_{GS} | Gate to Source Voltage | | 12 | 12 | V |
| | Drain Current -Continuous (Package limited) | T _C = 25 °C | 20 | 60 | |
| I_D | -Continuous | T _A = 25 °C | 13 ^{1a} | 27 ^{1b} | Α |
| | -Pulsed | | 40 | 120 | |
| E _{AS} | Single Pulse Avalanche Energy (Note 3) | | 21 | 97 | mJ |
| D | Power Dissipation for Single Operation $T_A = 25 ^{\circ}\text{C}$ | | 1.6 ^{1a} | 2.0 ^{1b} | W |
| P_{D} | Power Dissipation for Single Operation $T_A = 25 ^{\circ}C$ | | 0.8 ^{1c} | 0.9 ^{1d} | VV |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | -55 to | +150 | °C |

Thermal Characteristics

| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | 77 ^{1a} | 63 ^{1b} | |
|-----------------|---|-------------------|-------------------|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | 151 ^{1c} | 135 ^{1d} | °C/W |
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | 5.0 | 3.5 | |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|-----------|---------------|-----------|------------|------------|
| 13OD/15OD | FDPC8011S | Power Clip 33 | 13 " | 12 mm | 3000 units |

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

| Symbol | Parameter | Test Conditions | Туре | Min | Тур | Max | Units |
|--|--|--|----------|----------|----------|--------------|----------|
| Off Chara | octeristics | | | | | | |
| BV _{DSS} | Drain to Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0 V$ $I_D = 1 \text{ mA}, V_{GS} = 0 V$ | Q1 Q2 | 25 25 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_{J}}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250 \mu A$, referenced to 25 °C $I_D = 10 \text{ mA}$, referenced to 25 °C | Q1 Q2 | | 14 24 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 20 V, V _{GS} = 0 V V _{DS} = 20 V, V _{GS} = 0 V | Q1 Q2 | | | 1 500 | μΑ μΑ |
| I _{GSS} | Gate to Source Leakage Current, Forward | V _{GS} = 12 V/-8 V, V _{DS} = 0 V V _{GS} = 12 V/-8 V, V _{DS} = 0 V | Q1 Q2 | | | ±100 ±100 | nA nA |

On Characteristics

| V _{GS(th)} | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250 \mu A$ $V_{GS} = V_{DS}, I_D = 1 mA$ | Q1 Q2 | 0.8 1.1 | 1.2 1.4 | 2.2 2.2 | V |
|---------------------|----------------------------------|---|----------|------------|------------|------------|---------|
| $\Delta V_{GS(th)}$ | Gate to Source Threshold Voltage | I _D = 250 μA, referenced to 25 °C | Q1 | | -4 | | mV/°C |
| ΔT_{J} | Temperature Coefficient | I _D = 10 mA, referenced to 25 °C | Q2 | | -3 | | IIIV/ C |
| | | V _{GS} = 10 V, I _D = 13 A | | | 4.6 | 6.0 | |
| | | $V_{GS} = 4.5 \text{ V}, I_D = 12 \text{ A}$ | Q1 | | 5.4 | 7.3 | |
| r | Drain to Source On Resistance | $V_{GS} = 10 \text{ V}, I_D = 13 \text{ A}, T_J = 125 \text{ °C}$ | | | 5.6 | 7.3 | mΩ |
| r _{DS(on)} | Drain to Source On Resistance | $V_{GS} = 10 \text{ V}, I_D = 27 \text{ A}$ | | | 1.2 | 1.8 | 11152 |
| | | $V_{GS} = 4.5 \text{ V}, I_D = 24 \text{ A}$ | Q2 | | 1.4 | 2.1 | |
| | | $V_{GS} = 10 \text{ V}, I_D = 27 \text{ A}, T_J = 125 ^{\circ}\text{C}$ | | | 1.7 | 2.4 | |
| a | Forward Transconductance | V _{DS} = 5 V, I _D = 13 A | Q1 | | 97 | | S |
| 9 _{FS} | Forward Transconductance | $V_{DS} = 5 \text{ V}, I_{D} = 27 \text{ A}$ | Q2 | | 231 | | 3 |

Dynamic Characteristics

| C _{iss} | Input Capacitance | Q1: V _{DS} = 13 V, V _{GS} = 0 V, f = 1 MHZ | Q1 Q2 | 1240 4335 | pF |
|------------------|------------------------------|---|----------|--------------|----|
| C _{oss} | Output Capacitance | Q2: | Q1 Q2 | 332 1126 | pF |
| C _{rss} | Reverse Transfer Capacitance | V _{DS} = 13 V, V _{GS} = 0 V, f = 1 MHZ | Q1 Q2 | 49 143 | pF |
| R_g | Gate Resistance | | Q1 Q2 | 0.4 0.5 | Ω |

Switching Characteristics

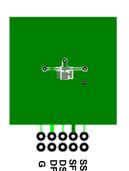
| t _{d(on)} | Turn-On Delay Time | | | Q1 Q2 | 7 13 | ns |
|---------------------|-------------------------------|--|---|----------|------------|----|
| t _r | Rise Time | Q1: V _{DD} = 13 V, I _D = 13 | B A, $R_{GEN} = 6 \Omega$ | Q1 Q2 | 2 5 | ns |
| t _{d(off)} | Turn-Off Delay Time | Q2: V _{DD} = 13 V, I _D = 27 | 7 A P = 6 O | Q1 Q2 | 20 38 | ns |
| t _f | Fall Time | VDD = 13 V, 1D = 21 | 7 A, NGEN - 0 12 | Q1 Q2 | 2 4 | ns |
| Qg | Total Gate Charge | V _{GS} = 0 V to 10 V | | Q1 Q2 | 19 64 | nC |
| Qg | Total Gate Charge | V _{GS} = 0 V to 4.5 V | $V_{DD} = 13 \text{ V},$ $I_{D} = 13 \text{ A}$ | Q1 Q2 | 9 30 | nC |
| Q _{gs} | Gate to Source Gate Charge | | Q2 V _{DD} = 13 V, | Q1 Q2 | 2.6 9.3 | nC |
| Q _{gd} | Gate to Drain "Miller" Charge | | $I_{D} = 27 \text{ A}$ | Q1 Q2 | 2.3 7.7 | nC |

Electrical Characteristics T_J = 25 °C unless otherwise noted

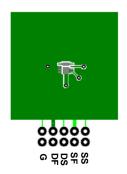
| Symbol | Parameter | Test Conditions | Туре | Min | Тур | Max | Units |
|-----------------|---------------------------------------|--|----------|-----|------------|------------|-------|
| Drain-Soເ | rce Diode Characteristics | | | | | | |
| V _{SD} | Source to Drain Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_S = 13 \text{ A}$ (Note 2) $V_{GS} = 0 \text{ V}, I_S = 27 \text{ A}$ (Note 2) | | | 0.8 0.8 | 1.2 1.2 | V |
| t _{rr} | Reverse Recovery Time | Q1 I _F = 13 A, di/dt = 100 A/μs | Q1 Q2 | | 22 30 | | ns |
| Q _{rr} | Reverse Recovery Charge | Q2 $I_F = 27 \text{ A}, \text{ di/dt} = 300 \text{ A/}\mu\text{s}$ | Q1 Q2 | | 8 32 | | nC |

Notes

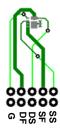
 $1.R_{\theta,JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,CA}$ is determined by the user's board design.



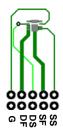
a. 77 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 63 °C/W when mounted on a 1 in² pad of 2 oz copper



c. 151 °C/W when mounted on a minimum pad of 2 oz copper



d. 135 °C/W when mounted on a minimum pad of 2 oz copper

- 2 Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.
- 3. Q1 :EAS of 21 mJ is based on starting $T_J = 25$ °C; N-ch: L = 1.2 mH, $I_{AS} = 6$ A, $V_{DD} = 23$ V, $V_{GS} = 10$ V. 100% test at L= 0.1 mH, $I_{AS} = 14.5$ A. Q2: EAS of 97 mJ is based on starting $T_J = 25$ °C; N-ch: L = 0.6 mH, $I_{AS} = 18$ A, $V_{DD} = 23$ V, $V_{GS} = 10$ V. 100% test at L= 0.1 mH, $I_{AS} = 32.9$ A.

Typical Characteristics (Q1 N-Channel) T_J = 25 °C unless otherwise noted

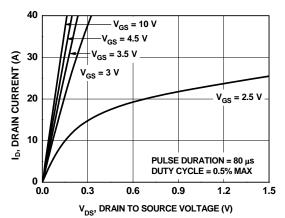


Figure 1. On Region Characteristics

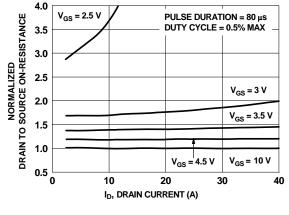


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

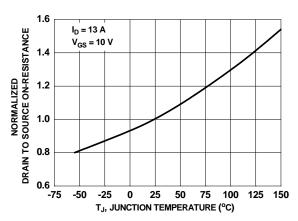


Figure 3. Normalized On Resistance vs Junction Temperature

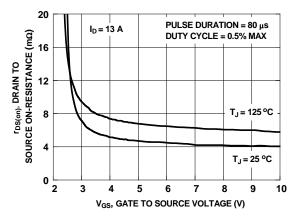


Figure 4. On-Resistance vs Gate to Source Voltage

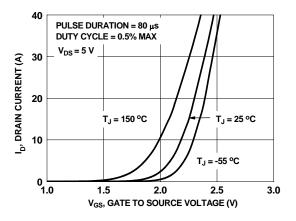


Figure 5. Transfer Characteristics

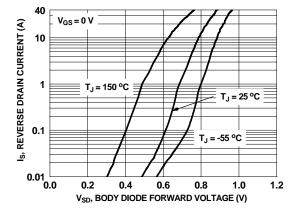


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (Q1 N-Channel) T_J = 25 °C unless otherwise noted

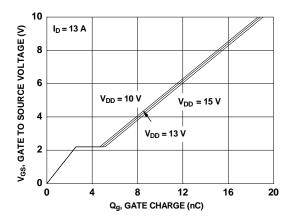


Figure 7. Gate Charge Characteristics

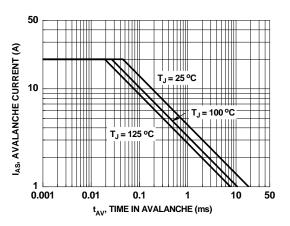


Figure 9. Unclamped Inductive Switching Capability

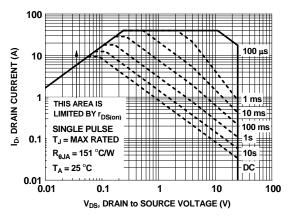


Figure 11. Forward Bias Safe Operating Area

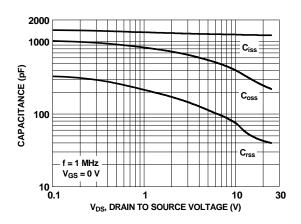


Figure 8. Capacitance vs Drain to Source Voltage

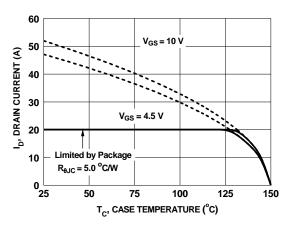


Figure 10. Maximum Continuous Drain Current vs. Ambient Temperature

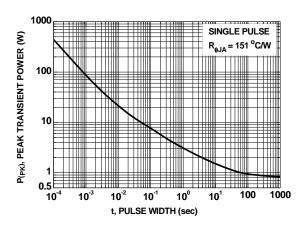


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q1 N-Channel) T_J = 25 °C unless otherwise noted

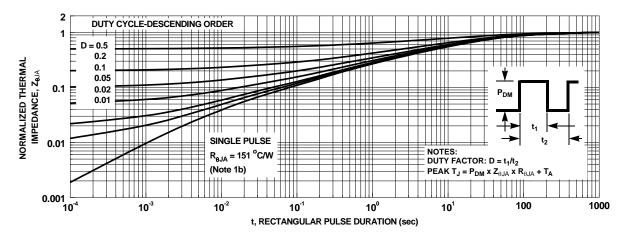


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

Typical Characteristics (Q2 N-Channel) T_J = 25 °C unlenss otherwise noted

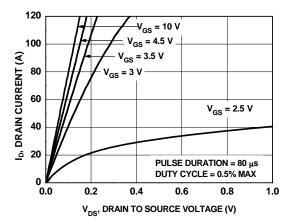
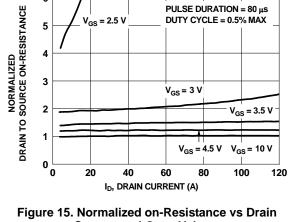


Figure 14. On-Region Characteristics



Current and Gate Voltage

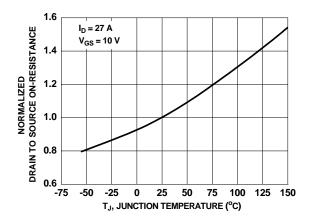


Figure 16. Normalized On-Resistance vs Junction Temperature

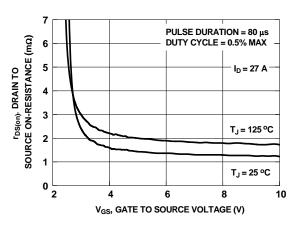


Figure 17. On-Resistance vs Gate to **Source Voltage**

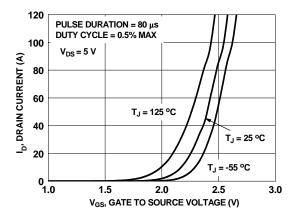


Figure 18. Transfer Characteristics

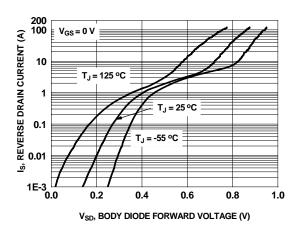


Figure 19. Source to Drain Diode **Forward Voltage vs Source Current**

Typical Characteristics (Q2 N-Channel) T_J = 25 °C unlenss otherwise noted

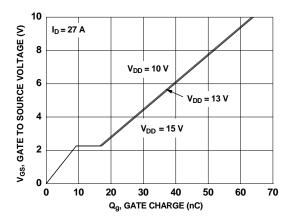


Figure 20. Gate Charge Characteristics

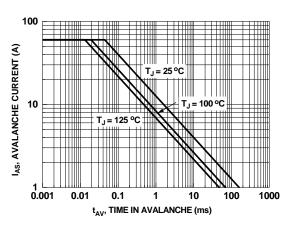


Figure 22. Unclamped Inductive Switching Capability

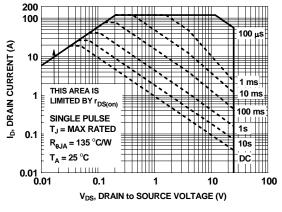


Figure 24. Forward Bias Safe Operating Area

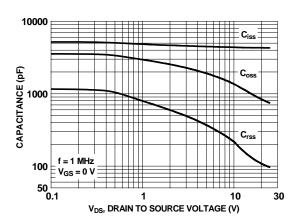


Figure 21. Capacitance vs Drain to Source Voltage

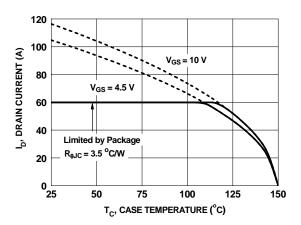


Figure 23. Maximum Continuouns Drain Current vs Ambient Temperature

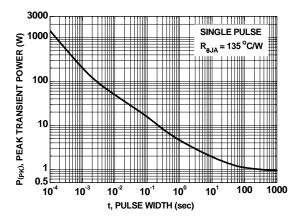


Figure 25. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q2 N-Channel) $T_J = 25$ °C unlenss otherwise noted

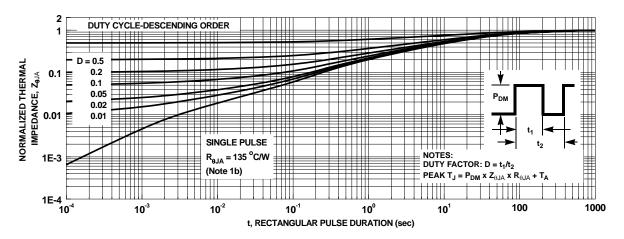


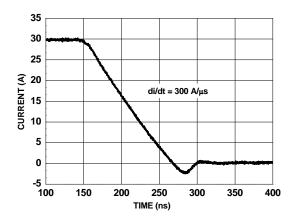
Figure 26. Junction-to-Ambient Transient Thermal Response Curve

Typical Characteristics (continued)

SyncFETTM Schottky body diode Characteristics

Fairchild's SyncFETTM process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 27 shows the reverse recovery characteristic of the FDPC8011S.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.



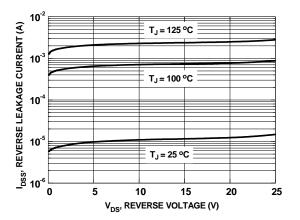
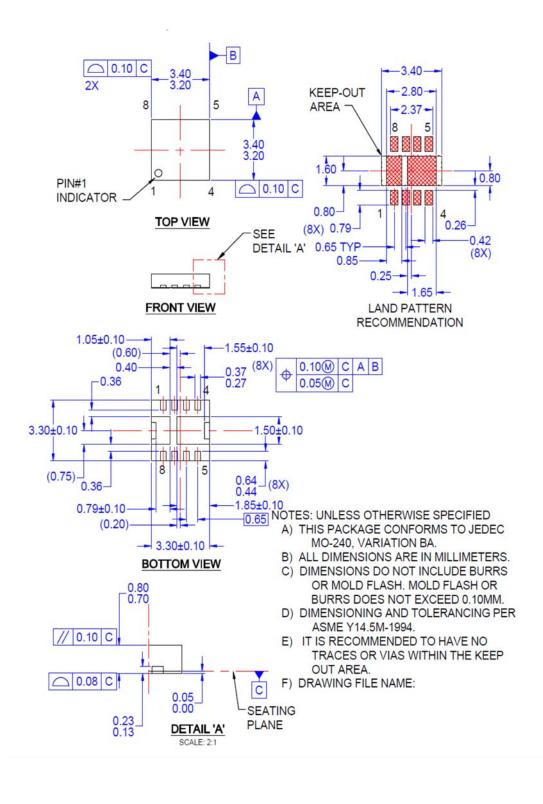


Figure 27. FDPC8011S SyncFETTM body diode reverse recovery characteristic

Figure 28. SyncFETTM body diode reverse leakage versus drain-source voltage

Dimensional Outline and Pad Layout







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